## CD74HCT4066-Q1 **HIGH-SPEED CMOS LOGIC** QUAD BILATERAL SWITCH

SCLS581B - APRIL 2004 - REVISED APRIL 2008

- **Qualified for Automotive Applications**
- Low ON Resistance – 25  $\Omega$  Typical (V<sub>CC</sub> = 4.5 V)
- **Fast Switching and Propagation Speeds**
- Low OFF Leakage Current
- Wide Operating Temperature Range: -40°C to 125°C

#### description/ordering information

The CD74HCT4066 contains four independent digitally controlled analog switches that use silicon-gate CMOS technology to achieve operation speeds similar to LSTTL, with the low power consumption of standard CMOS integrated circuits.

These switches feature the characteristic linear ON resistance of the metal-gate CD4066B. Each switch is turned on by a high-level voltage on its control input.

- **Direct LSTTL Input Logic Compatibility:**  $V_{IL} = 0.8 V Max, V_{IH} = 2 V Min$
- CMOS Input Compatibility:  $I_I \leq 1 \mu A$  at  $V_{OL}$ , VOH

	M OR PW PACKAGE (TOP VIEW)								
1Y [ 1Z [ 2Z [ 2Y [ 3E [ GND [	1 2 3 4 5 6 7	υ	14 13 12 11 10 9 8	] V <sub>CC</sub> ] 1E ] 4E ] 4Y ] 4Z ] 3Z ] 3Y					

#### **ORDERING INFORMATION<sup>†</sup>**

T <sub>A</sub>	PACK	AGE <sup>‡</sup>	ORDERABLE PART NUMBER <sup>§</sup>	TOP-SIDE MARKING		
-40°C to 125°C	SOIC – M	Reel of 2500	CD74HCT4066QM96Q1	HCT4066Q		
	TSSOP – PW	Reel of 2000	CD74HCT4066QPWRQ1	HK4066Q		

<sup>†</sup> For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at http://www.ti.com.

<sup>‡</sup> Package drawings, thermal data, and symbolization are available at http://www.ti.com/packaging.

§ The suffix 96 denotes tape and reel.

#### **FUNCTION TABLE**

INPUT nE	SWITCH
L	Off
Н	On

H = High level L = Low level



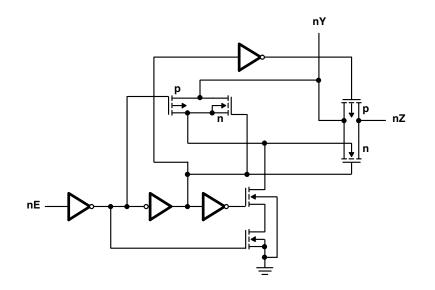
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#### logic diagram (positive logic)



#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, V <sub>CC</sub> (see Note 1)	0.5 V to +7 V
Input clamp current, $I_{IK}$ (V <sub>I</sub> < -0.5 V or V <sub>I</sub> > V <sub>CC</sub> + 0.5 V)	±20 mA
Output clamp current, $I_{OK}$ ( $V_O < -0.5$ V or $V_O > V_{CC} + 0.5$ V)	±20 mA
Switch current, I <sub>O</sub> (see Note 2) ( $V_O > -0.5$ V or $V_O < V_{CC} + 0.5$ V)	±25 mA
Output source or sink current per output pin, $I_O$ ( $V_O > -0.5$ V or $V_O < V_{CC} + 0.5$ V)	±25 mA
Continuous current through V <sub>CC</sub> or GND	±50 mA
Package thermal impedance, $\theta_{JA}$ (see Note 3): D package	86°C/W
PW package	113°C/W
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltages referenced to GND unless otherwise specified.

- 2. In certain applications, the external load-resistor current may include both V<sub>CC</sub> and signal-line components. To avoid drawing V<sub>CC</sub> current when switch current flows into the transmission gate inputs (terminals 1, 4, 8, and 11), the voltage drop across the bidirectional switch must not exceed 0.6 V (calculated from ron values shown in the electrical characteristics table). No V<sub>CC</sub> current flows through  $R_L$  if the switch current flows into terminals 2, 3, 9, and 10.
- 3. The package thermal impedance is calculated in accordance with JESD 51-7.



#### recommended operating conditions (see Note 4)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage		4.5	5.5	V
V <sub>IH</sub>	High-level input voltage		2		V
VIL	Low-level input voltage			0.8	V
VI	Input voltage		0	$V_{CC}$	V
Vo	Output voltage		0	V <sub>CC</sub>	V
tt	Input transition (rise and fall) time	$V_{CC} = 4.5 V$	0	500	ns
T <sub>A</sub>	Operating free-air temperature		-40	125	°C

NOTES: 4. All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CO	v	v <sub>cc</sub>	T,	<sub>A</sub> = 25°C	;	T <sub>A</sub> = −40°C TO 125°C		UNIT		
					MIN	TYP	MAX	MIN	MAX		
I <sub>IL</sub>	Any control	V <sub>CC</sub> or GND	5.5 V			±0.1		±1	μA		
I <sub>IZ</sub>	$V_{IS} = V_{CC}$ or GND	V <sub>IL</sub>	5.5 V			±0.1		±1	μA		
_	l <sub>O</sub> = 1 mA,	$V_{IS} = V_{CC}$ or GND	V <sub>CC</sub>	4.5 V		25	80		128	0	
r <sub>on</sub>	See Figure 7	$V_{IS} = V_{CC}$ to GND	V <sub>CC</sub>	4.5 V		35	95		142	Ω	
$\Delta r_{on}$	Between any two sw	itches	V <sub>CC</sub>	4.5 V		1				Ω	
ICC			V <sub>CC</sub> or GND	5.5 V			2		40	μA	
ΔI <sub>CC</sub>	Per input pin: 1 unit l See Note 5	V <sub>CC</sub> – 2.1 V	4.5 V to 5.5 V		100	360		490	μA		
Cl	Control inputs	Control inputs					10		10	pF	

NOTE 5: For dual-supply systems, theoretical worst case (V<sub>1</sub> = 2.4 V, V<sub>CC</sub> = 5.5 V) specification is 1.8 mA.

#### **HCT** input loading

INPUT	UNIT LOADS <sup>†</sup>
All	1

 $^{\dagger}$  Unit load is  $\Delta I_{CC}$  limit specified in the electrical characteristics table, e.g., 360  $\mu A$  max at 25°C.



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# switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 6)

PARAMETER	FROM	TO		v <sub>cc</sub>	Тд	∖ = 25°C	;	T <sub>A</sub> = −40°C TO 125°C		UNIT	
	(INPUT)	(OUTPUT)	CAPACITANCE		MIN	TYP	MAX	MIN	MAX		
	h Var 7	7.001	C <sub>L</sub> = 15 pF	5 V		4					
t <sub>pd</sub>	Y or Z	Z or Y	C <sub>L</sub> = 50 pF	4.5 V			12		18	ns	
	-	× -	C <sub>L</sub> = 15 pF	5 V		9					
t <sub>en</sub>	E	Y or Z	C <sub>L</sub> = 50 pF	4.5 V			24		36	ns	
		V or 7	C <sub>L</sub> = 15 pF	5 V		14				ns	
t <sub>dis</sub>	E	Y or Z	$C_L = 50 \text{ pF}$	4.5 V			35		53		

## operating characteristics, $V_{CC}$ = 5 V, $T_A$ = 25°C, input $t_r$ , $t_f$ = 6 ns

	PARAMETER	TYP	UNIT
C <sub>pd</sub>	Power dissipation capacitance (see Note 6)	38	pF

NOTE 6: C<sub>pd</sub> is used to determine the dynamic power consumption (P<sub>D</sub>), per package.

 $P_{D} = (C_{pd} \times V_{CC}^{2} \times f_{I}) + \Sigma (C_{L} + C_{S}) \times V_{CC}^{2} \times f_{O}$ 

 $f_{O}$  = output frequency

 $f_{I} = input frequency$ 

 $C_L$  = output load capacitance

 $C_{S}$  = switch capacitance

 $V_{CC}$  = supply voltage

### analog channel characteristics, $T_A = 25^{\circ}C$

	PARAMETER	TEST CONDITIONS	V <sub>CC</sub>	TYP	UNIT
f <sub>max</sub>	Switch frequency response bandwidth at -3 dB	See Figure 2 and Figure 8 and Notes 7 and 8	4.5 V	200	MHz
	Crosstalk between any two switches	See Figure 1 and Figure 9 and Notes 8 and 9	4.5 V	-72	dB
	Total harmonic distortion	See Figure 3, 1 kHz, V <sub>IS</sub> = 4 V <sub>P-P</sub>	4.5 V	0.023	%
	Control to switch feedthrough noise	See Figure 4	4.5 V	130	mV
	Switch OFF signal feedthrough	See Figure 5 and Figure 9 and Notes 8 and 9	4.5 V	-72	dB
CS	Switch input capacitance			5	pF

NOTES: 7. Adjust input voltage to obtain 0 dBm at output, f = 1 MHz.

8.  $V_{IS}$  is centered at  $V_{CC}/2$ .

9. Adjust input for 0 dBm at  $V_{\text{IS}}.$ 



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#### PARAMETER MEASUREMENT INFORMATION

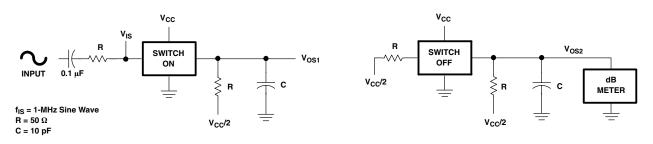


Figure 1. Crosstalk Between Two Switches Test Circuit

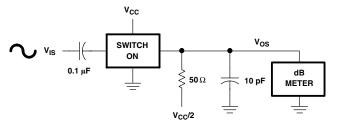


Figure 2. Frequency-Response Test Circuit

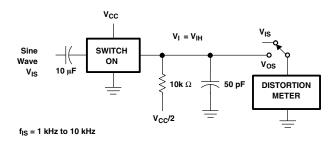


Figure 3. Total Harmonic Distortion Test Circuit

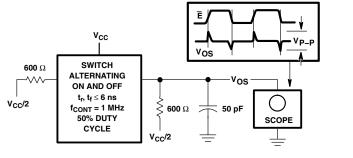


Figure 4. Control-to-Switch Feedthrough Noise Test Circuit

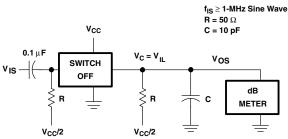
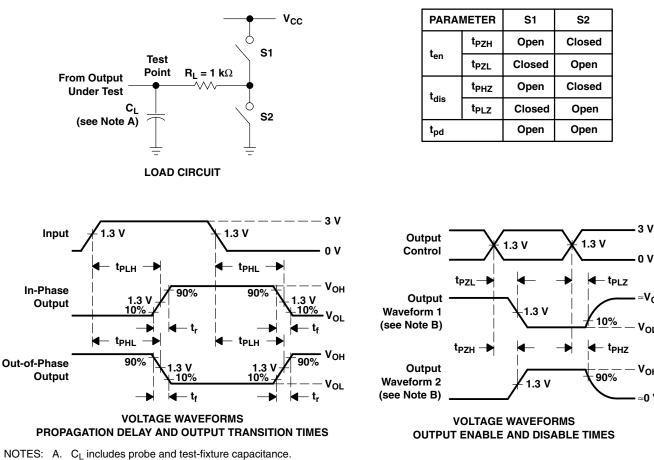


Figure 5. Switch OFF Signal Feedthrough Test Circuit



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0 V

≈V<sub>CC</sub>

VOL

v<sub>он</sub>

≈0 V

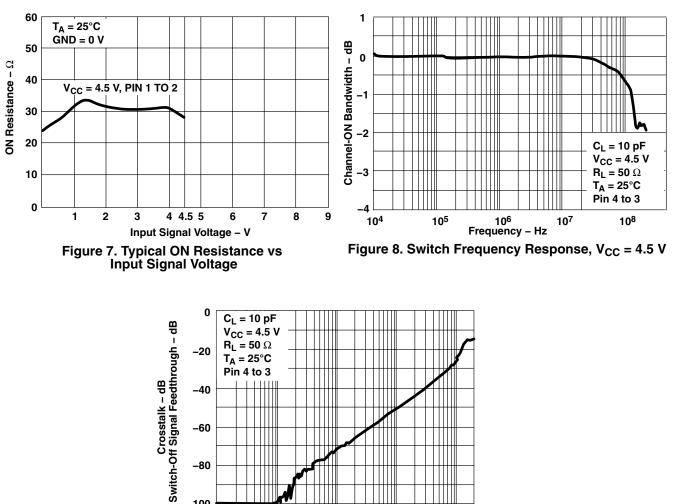
#### PARAMETER MEASUREMENT INFORMATION

- - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control. C. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following
  - characteristics:  $PRR \le 1$  MHz,  $Z_0 = 50 \Omega$ ,  $t_r = 6$  ns,  $t_f = 6$  ns.
  - D. For clock inputs, f<sub>max</sub> is measured with the input duty cycle at 50%.
  - E. The outputs are measured one at a time, with one input transition per measurement.
  - F.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
  - G.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
  - H. t<sub>PLH</sub> and t<sub>PHL</sub> are the same as t<sub>pd</sub>.

#### Figure 6. Load Circuit and Voltage Waveforms



**TYPICAL CHARACTERISTICS** 



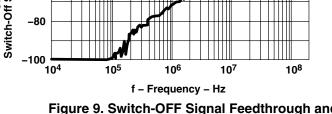


Figure 9. Switch-OFF Signal Feedthrough and Crosstalk vs Frequency,  $V_{CC}$  = 4.5 V



24-Jan-2013

## PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing		Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
CD74HCT4066QM96Q1	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	HCT4066Q	Samples
CD74HCT4066QPWRQ1	ACTIVE	TSSOP	PW	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	HK4066Q	Samples
D24066QM96G4Q1	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	HCT4066Q	Samples
HCT4066QPWRG4Q1	ACTIVE	TSSOP	PW	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	HK4066Q	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> Only one of markings shown within the brackets will appear on the physical device.

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## PACKAGE OPTION ADDENDUM

24-Jan-2013

#### OTHER QUALIFIED VERSIONS OF CD74HCT4066-Q1 :

• Catalog: CD74HCT4066

NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

## PACKAGE MATERIALS INFORMATION

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### TAPE AND REEL INFORMATION





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74HCT4066QPWRQ1	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
HCT4066QPWRG4Q1	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

TEXAS INSTRUMENTS

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## PACKAGE MATERIALS INFORMATION

14-Mar-2013



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74HCT4066QPWRQ1	TSSOP	PW	14	2000	367.0	367.0	35.0
HCT4066QPWRG4Q1	TSSOP	PW	14	2000	367.0	367.0	35.0

D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.



PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



A. An integration of the information o

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153



# PW (R-PDSO-G14)

# PLASTIC SMALL OUTLINE



- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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